Is the M ultichannel K ondo M odel A ppropriate to D escribe the Single E lectron Transistor?

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We investigate the low-tem perature dynam ics of single electron boxes and transistors close to their degeneracy point using renorm alization group methods. We show that interm ode scattering is a relevant perturbation and always drives the system to the two-channel K ondo xed point, where the two channels correspond to the real spins of the conduction electrons. H ow ever, the crossover tem perature T , below which M atveev's two-channel K ondo scenario [K A . M atveev, Phys. Rev. B 51, 1743 (1995)] develops decreases exponentially with the num ber of conduction modes in the tunneling junctions and is extrem ely sm all in most cases. A bove T the 'in nite channelm ode!' of R ef. 6 turns out to be a rather good approximation. We discuss the experimental limitations and suggest a new experimental setup to observe the multichannel K ondo behavior.

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I. IN TRODUCTION

The single electron box (SEB) and the single electron transistor (SET) are basic elements of mesoscopic devices and have been studied extensively.^{1,2} Both consist of a single sm allm etallic or sem iconducting box connected to one (single electron box, or SEB) or two (single electron transistor, or SET) leads. A dditionally, in the SET a gate electrode is attached to the box to control the actual charge on the dot (see Fig. 1).



FIG.1. Sketch of the single electron box (SEB) and the single electron transistor (SET).

The electrostatic energy of the box is well-described by the classical expression $^{\rm 1}$

$$H_{c} = \frac{e^{2}}{2c} n_{box} \frac{V_{g}C_{g}}{e}^{2}$$
; (1)

where C denotes the capacitance of the island, C_g is the gate capacitance, e is the electric charge, V_g stands for the gate voltage, and n_{box} is the number of extra electrons on the island. For box sizes in the 0:1 m range the capacitance C of the box can be small enough so that the charging energy $E_c = e^2 = 2C$ associated with putting an extra electron on the island can safely be around mV range. Therefore, unless $N_g = \frac{V_g C_g}{e}$ is a half-integer, it costs a nite energy to charge the island, and at low enough tem peratures the num ber of electrons on the island become es quantized and a C oulom b blockade develops provided the quantum uctuations are not too strong. In this C oulom b blockade regime the transport through the island is suppressed.

The situation is dram atically di erent for dim ensionless gate voltages N_g = $\frac{V_g C_g}{e}$ $n + 1 = 2.ForN_q = n + 1 = 2$ the two states $n_{box} = n$ and $n_{box} = n + 1$ become degenerate, and quantum uctuations between the island and the leads become important. Assuming that the m ean level spacing on the island is smaller than any energy scale (tem perature, $E_{\rm C}$, etc.) two scenarios have been suggested: (a) It has been proved by M atveev^{3;4} that if the leads are connected to the island via a single conduction mode then | close to the degeneracy point and at low enough temperature the physics of the SET (SEB) becomes identical to that of the two-channel K ondom odel. Indeed, the ngerprints of the two-channel K ondo behavior have been observed recently on sem iconducting single electron transistors.⁵ (b) In the opposite lim it one assumes that the tunneling to the island happens through an in nite number of identical modes.^{6;7} This model has been applied very successfully for the

description of metallic islands.⁸ The predictions of this in nite channel model are, however, very dierent from those of the two-channel K ondo model: the conductance of the SET, for instance, scales to zero as T in the two-channel K ondo picture,⁴ while it is proportional to $1 = \ln (E_C = T)$ in the in nite channel scenario.⁶

The purpose of the present paper is to treat the general case of nite conduction modes in the lead and to reconcile the apparent contradiction between the two pictures above. W e show that both models capture the physical properties of the SEB (SET), how ever, they are appropriate in very di erent regim es. Carrying out a renorm alization group analysis we show that there exists a crossover energy T . Above T , even for N 20 tunneling m odes the system is well characterized by the conductance of the tunnel junctions and the SEB (SET) is satisfactorily described by the 2N -channel model of Ref. 6. Nevertheless, for sm all m ode num bers pronounced deviations occur, and sim ilar deviations appear for larger values of N in the presence of pinholes in the junction, which offer a plausible explanation to the deviations observed in Ref.8.

Below T , on the other hand, the detailed structure of the tunneling m atrix becom es in portant: At very low T only a single conductance m ode dom inates the physics and a two-channelK ondo e ect develops. Unfortunately, in m ost situations T (and thus the K ondo tem perature $T_{\rm K}$ T) turns out to be extrem ely sm all, and the two-channelK ondo physics cannot be observed. In fact, very special experimental setups are needed to observe the two-channel K ondo behavior, as we shall discuss it in detail in our concluding section.

The paper is organized as follows: In Sec. II we describe the models applied. Secs. III and IV are devoted to the analysis of the single electron box and the single electron transistor, respectively. Finally, in Sec. V we discuss the possibility of experim ental observations of the low energy K ondo-like behavior and sum marize our conclusions.

II.THE MODELS

A.Ham iltonian of the SEB

For the sake of sim plicity, let us rst concentrate on the single electron box and generalize our results to the SET later on. U sually, the lead is described by m eans of N independent non-interacting one-dimensional electron m odes:

$$H_{lead} = \begin{array}{c} X^{N} X \\ C_{n ; lead}^{V} C_{n ; lead}^{V} C_{n ; lead}; \end{array}$$
(2)

where c_{n}^{y} crates an electron on the box with spin , mode index m and energy . (Note that to avoid confusion, we do not follow the usual term inology and

use deliberately the expression conduction mode instead of the wording 'conductance channels', more frequent in the literature.)

In the present work we assume that the level spacing at the island is much smaller than any energy scale in the problem, and therefore these discrete levels may be represented as a single particle continuum on the island. This assumption is crucial to obtain the K ondo physics discussed in this paper, since the level spacing provides an infrared cut-o which ultimately kills the logarithm ic singularities and the K ondo e ect. Based on these assumptions we express the H am iltonian of the island as¹

$$H_{box} = \begin{cases} X^{M} & X \\ & & \\ & m = 1 \end{cases} + E_{C} (n_{box} V_{g}C_{g} = e)^{2} : \end{cases}$$
(3)

In Eq. (3) we assumed M independent modes on the box, 9 and de ned the number $n_{\rm box}$ of electrons on the island as

$$n_{box} = \frac{X^{M} X}{\sum_{m=1}^{W} c_{m,box}^{W} c_{m,box}^{W} c_{m,box}^{W}} (4)$$

where the symbol: :::: : denotes norm alordering.

As usually, in Eq. (3) we implicitly used the assumption that the collective charge excitations decouple from the single particle excitations² and that the electronelectron interaction can be fully taken into account by the classical C oulom b interaction term. The validity of this approximation relies heavily on the fact the collective charge excitations relax extrem ely fast compared to all other time scales involved.

The coupling of the box to the lead is described by a standard tunneling H am iltonian:

$$H_{tun} = \sum_{n=1m=1}^{X^{N}} X^{M} X T_{mn} c_{m}^{Y} c_{n} c_{n} c_{m} c_{m$$

where we neglected the energy dependence of the elements of the M \sim N tunneling matrix $T_{m,n}$

It is very in portant that the tunneling is diagonal in the spin indices, however, it is generally non-diagonal in the mode indices. As we shall see later, the twofold spin degeneracy is the basic origin of the very low temperature two-channelK ondo e ect.³ O noem agnetic eld is applied the sym m etry between spin up and spin down conduction electrons is broken, and the system ows to the single channelK ondo xed point.

The tunneling Ham iltonian of the SET diers only slightly from that of the SEB. In this case there are two leads that are connected to the island. However, as rst shown by Averin and Nazarov,¹⁰ at temperatures larger than the level spacing coherent processes connecting the two leads are strongly suppressed. Therefore, one can form ally separate from each-other those single particle states on the island which participate in the tunneling from the rst and the second lead, respectively.⁴ These tunneling processes are then only correlated by the very fast C oulom b interaction which allows for the presence of only one excess electron on the island.

Thus for the SET the e ective H am iltonian of the island becomes⁴:

$$H_{box} = \frac{X^{M} X}{m = 1} c^{(1)Y}_{m \ box} c^{(1)}_{m \ box} c^{(1)}_{m \ box} + c^{(2)Y}_{m \ box} c^{(2)}_{m \ b$$

where the indices (1) and (2) refer to single particle states participating in the tunneling from the rst and second leads, respectively, and the number operators $n_{\rm box}^{(1)}$ and $n_{\rm box}^{(2)}$ are de ned similarly to Eq. (4).

The tunneling Ham iltonian of the SET reads:

$$H_{tun} = X_{m_n c_m}^{(f)} T_{m_n c_m}^{(f)} C_{m_{tot}}^{(f)} C_{n_{tot}}^{(f)} C_{n_{tot}}^{(f)}$$

where the index f refers to the two junctions. For the sake of simplicity, we assumed that the number of m odes in the two leads (N $^{(1)}$ and N $^{(2)}$) and the number of tunneling m odes on the island (M $^{(1)}$ and M $^{(2)}$) is identical for both junctions(N $^{(1)}$ = N $^{(2)}$ = N and M $^{(1)}$ = M $^{(2)}$ = M). This simplication does not m odify our results because the two tunneling m atrices $T_{m\,n}^{(1)}$ and $T_{m\,n}^{(2)}$ are assumed to be completely uncorrelated.

In the following we focus to the vicinity of the degeneracy points, V C_G = e = n + 1=2. As already mentioned in the introduction at these gate voltages the charge states $n_{box} = n$ and $n_{box} = n + 1$ become degenerate and quantum uctuations dominate. For temperatures (energy scales) below the charging energy E_C = e²=2C one can safely project out all the other charging states, represent the two states $n_{box} = n + 1=2$ 1=2 as two states of a pseudospin S_z = 1=2, and rewrite the tunneling part of SEB Ham iltonian in the following form :

$$H = C_{n}^{Y} C_{n}; C_{n}; hS_{z}$$
(7)

$$; ; {}^{n=1} + (C_{n}^{Y}; T_{n}; {}^{m} + S C_{m}; + hx:);$$

$$; {}^{o}; ; {}^{n}; {}^{n};$$

where the 'orbital pseudospins' ; = (${}^{0}box^{0}$; ${}^{0}lead^{0}$) indicate the position of an electron and couple to S, = $_{x}$ i $_{y}$ denote Paulimatrices, and the index n takes values n = 1;::;N (N $_{lead}$ = N and N $_{box}$ = M). The eld h = e VC $_G$ =C m easures the distance from the degeneracy point, with V = V $e\,(n+1{=}2){=}C_G$.

For the SET Eq. (7) gets modiled in that the two leads provide two conduction electron 'channels' (f = 1;2) coupled to the charge pseudospin:

$$H_{tun} = \begin{pmatrix} X \\ (c^{(f)}_{n}, T_{n,m}^{(f)} + S c^{(f)}_{0m}, + hc) \end{pmatrix}$$
(8)

Note that the 'channel' label f has a role essentially different from that of the real spin of the electrons: W hile there is a full SU (2) symmetry associated to the latter, the former is merely a conserved quantity (corresponding to a U (1) symmetry only).

In the formulation above the case M = N = 1 corresponds to M atveev's two-channel K ondo m odel $_{
m p}^3$ while in the lim it M = N ! 1 and $T_{nm} = _{nm} T$ 1= N we recover the in nite channelm odel⁶ m entioned in the Introduction. O by jously, both lim its are som ew hat speci c: In m any realistic system s M ; N > 1 and the rst approxin ation seems to be inadequate. The second approxim ation, on the other hand, contains an articial SU (2N) symmetry: There is no reason for the tunneling matrix element to be diagonal in the mode indices at all, and even more to have identical matrix element in each tunneling mode. In fact, any defect, roughness, etc. present in a real junction will produce cross-channel tunneling, and even the simplest models of a perfect tunnel junction with N = M give di erent tunneling eigenvalues for the di erent tunneling modes. The philosophy behind this second approach is that the only physically relevant param eter is the conductance of the junction and therefore the articial symmetry introduced has no e ect. As we shall see, this philosophy is only partially justi ed: cross-mode tunneling | breaking this articial SU (2N) symmetry is in reality a relevant perturbation and leads the system ultimately to the two-channel K ondo xed point.

III.PERTURBATIVE SCALING ANALYSIS OF THE SEB

It has been shown longtime ago that the Ham iltonian of Eq. (7) generates logarithm ic singularities when perturbation theory in the tunneling am plitude is developed.³ To deal with these logarithm ic singularities one has to sum up the perturbation series up to in nite order. The easiest way to do this is by constructing the renorm alization group (RG) equations. Fortunately, this straightforw and but rather tedious calculation can be avoided by rewriting the Ham iltonian (7) in the following form:

$$H_{int} = \begin{cases} X^{3} & X \\ & \\ & \\ & \\ & \\ i=1 ; ; ;^{0}; r; r^{0} \end{cases} V_{rr^{0}}^{i} c^{+}_{r} c_{r^{0}} ; \qquad (9)$$

and observing that Eq. (9) is form ally identical to the H am iltonian of a non-commutative two-level system .¹¹ The indices r and r⁰ in Eq. (9) take the values r; r⁰ = (1;::;M + N), the ⁱ's denote P aulim atrices (ⁱ = 2Sⁱ), and the $V_{rr^0}^{i}$'s can be written in a block matrix notation as

$$V^{x} = \frac{1}{2} \begin{pmatrix} 0 & T \\ T^{y} & 0 \end{pmatrix}$$
; (10)

$$V^{y} = \frac{1}{2i} \quad \begin{bmatrix} 0 & T \\ T^{+} & 0 \end{bmatrix}$$
; (11)

$$V^{z} = \begin{array}{c} Q & 0 \\ 0 & Q \end{array} ; \qquad (12)$$

where we introduced the tensor notation $T_{m\,n}$! T. The M M and N N Herm itian matrices Q and Q vanish in the bare Ham iltonian, but they are dynam ically generated under scaling. They correspond to charging state dependent back scattering o the tunnel junction:

$$H_{back} = \begin{array}{c} X & X^{N} \\ 2S_{z} & Q_{nn^{0}}C_{n}^{Y} \\ ;^{0}; ;^{0} & n;n^{0}=1 \\ X^{M} \\ + & Q_{mm^{0}}C_{m}^{Y} \\ m;m^{0}=1 \end{array}$$
(13)

The scaling equations of the two-level system have been rst derived in Ref. 12 and its possible xed points and their stability have been carefully analyzed in Ref. 13. U sing thism apping we can easily construct the RG equations for the SEB:

$$\frac{dt}{dx} = 2 (tq qt)$$
2t Trftt^yq + 2Trfqqq + 2Trfqqq ; (15)

$$\frac{dq}{dx} = t^{y}t \quad 4qTrftt^{y}g; \qquad (16)$$

$$\frac{dq}{dx} = tt^{y} \quad 4qTrftt^{y}g:$$
 (17)

Here we introduced the scaling variable x = $\ln (E_c = m \ axfT; !; :g)$ and de ned dimensionless couplings as $t_{m \ n}$ $(g_m^{\text{box}} \circ g_n^{\text{lead}})^{1=2} T_{m \ n}$ (and sim ilarly, $q_{m \ m} \circ (g_m^{\text{box}} \circ g_n^{\text{box}})^{1=2} Q_{m \ m} \circ$, and $g_{n \ n} \circ (g_n^{\text{lead}} \circ g_n^{\text{lead}})^{1=2} \mathcal{Q}_{n \ n} \circ)$ with S_m^{box} $(g_n^{\text{lead}} \circ g_n^{\text{lead}})$ the density of states at the Ferm ienergy in mode m (mode n) of the box (lead).

The scaling equation for the eld h can be obtained from that of the splitting in the two-level system problem :

$$\frac{dh}{dx} = 4hTrftteg:$$
(18)

These scaling equations are appropriate provided g Trftt^yg < 1, otherwise the perturbative RG breaks down. They must be solved with the initial condition q(x = 0) = q(x = 0) = 0 and $t(x = 0) = t^{\text{bare}}$. Away

from the degeneracy point the \magnetic eld", i.e. the deviation from the degeneracy point is a relevant perturbation, and the scaling must be cut o at an energy scale h determined selfconsistently from the condition $h(x = ln(E_C = h)) = h$.

Up to logarithm ic accuracy, the conductivity can then be expressed in terms of the scaled dimensionless tunneling rate t (x = $\ln \mathbb{E}_{\mathbb{C}} = m \operatorname{axfT}$; h g]) as

$$G(T) = G_0 Trft(x)t^{y}(x)g$$
 (19)

where $G_0 = 8^2 e^2 = h$ denotes a universal conductance unit.

The analogues of Eqs. (15-17) have been analyzed very carefully in Refs. 13, where it was shown by means of a system atic 1=N $_{\rm s}$ expansion (N $_{\rm s}$ being the spin of the electrons) that they have a unique stable xed point, identical to the two-channel K ondo xed point. At this latter two orbital quantum num bers prevail, and the others becom e irrelevant. In the present context this statem ent means that there will be a unique 'e ective tunneling mode' in the lead (it is some combination of the original tunneling modes in the lead), and another unique 'tunneling mode' in the box (also a linear combination of the originalmodes in the box): The T = 0 e ective H am iltonian of the model at the degeneracy point corresponds to tunneling between these two modes only, and all the other modes can be neglected. This theorem therefore justi es the use of M atveev's e ective m odel at very low tem peratures even if the num ber of m odes in the lead or the box is larger than one.

However, as we show now, the temperature T , below which the two channel K ondo behavior appears turns out to be extrem ely sm all in most cases. To see this let us consider a tunneling junction with a rough tunneling surface, and a dimensionless conductance $g = G = G_0$. O by iously, in this case the matrix elements t_{mn} scale as g=N so that Trft^ytg g, and they have rant_{m n} dom sign or phase relative to each-other. The occupation dependent back scatterings q and q are generated by Eqs. (16) and (17), and their typical matrix elements can easily be estimated to be of order $1=N^{3=2}$. Therefore, the rst two terms in Eq. (15) can be estimated $q=N^2$, while the matrix elements to be sm aller than of the last term are dom inated by the term proportional to Trft^ytg and are of order $g^{3=2}=N$. Thus for large enough N M one can simply substitute q = q = 0 and the scaling equations reduce to:

$$\frac{dt}{dx} = 2tTrftt2g$$
 (20)

M ultiplying this equation by t^y and taking its trace we nally arrive at the scaling equation:

$$\frac{dg}{dx} = 4 g^2 ; \qquad (21)$$

which is identical to the one obtained in Ref. 6 using the 2N -channelm odel. The scaling equation for the elective

eld can also be expressed in term s of the dimensionless conductance:

$$\frac{dh}{dx} = 4gh :$$
 (22)

The above two scaling equations can readily be integrated to obtain:

$$g(x) = \frac{g_0}{1 + 4g_0 x} ; \qquad (23)$$

$$h(x) = \frac{h_0}{1 + 4g_0 x} :$$
 (24)

O by iously, in this approximation the physics of the SEB is completely characterized by the eld h and the conductance of the junction, and the details about the speci c structure of the junction or the tunneling amplitudes are unimportant.

It is easy to estimate the crossover scale T below which this approximation breaks down. The scaling towards the two-channelK ondo xed point is generated by the second order 'coherence' terms in Eqs. (15-17), while the third order term s tend to reduce all couplings to zero. Therefore the scale T is determined by the condition that the second and third order terms in Eqs. (15-17) be of the same order of magnitude, giving g 1=N. Replacing Eq. (23) by its asymptotic form g(x) 1=4x we nally obtain

T
$$E_{C} \exp f C N g$$
 (N 1); (25)

where C is a constant of the order of unity. In view of the experimental values of $E_{\rm C}$, this scale is extremely small for N > 10, which justimes the use of the 2N -channel model in many experimental setups.

In Figs.2 and 3 we show the typical scaling of g(x) for various N and M values, obtained by solving Eqs. (15-17) num erically. W hile in the Figures the initial hopping amplitudes have been generated completely random ly, sim ilar results have been obtained when we used simple m odel estimates for the $t_{m\,n}$'s. Eq. (23) approximates very nicely the conductance above T even for rather small channel numbers. Below T , however, the conductance starts to increase until it reaches its xed point value $g_{\rm fp}$ 1. In the inset we show that the scale T decreases exponentially with the number of modes in agreement with Eq. (25).



Scaling of the conductance of a single elec-FIG.2. tron box at its degeneracy point. The conductance curves have been calculated by integrating the full scaling equations Eqs. (15-17) with random ly generated tunneling matrix elements. The bare value of the conductance has been xed to be $g(0) = g_0 = 0.5$. The conductance follows more and more closely the in nite channel formula Eq. (23) as the number of modes N = M increases. In the inset the logarithm of the crossover tem peratures corresponding to the minim a of the conductance curves is plotted as a function of the num ber of modes. It scales linearly with the number of modes in agreem ent with the argum ents presented in the main text. N result from the uctuations of the The large error bars tunneling am plitude and indicate that for a sm all num ber of channels or pinholes substantial sam ple to sam ple deviations m ay occur.

IV.D ISCUSSION OF THE SET

To derive the scaling equations for the SET we repeated the derivation of the scaling equations of the twolevel system with a generalized version of the interaction H am iltonian (9). Here we only quote the results.

The scaling equations becom e:

$$+ 2Trfq^{(L)}q^{(L)}q; \qquad (26)$$

$$\frac{dq^{(1)}}{dx} = t^{(f)Y}t^{(f)} \quad 4q^{(f)} \quad Trft^{(f^0)}t^{(f^0)Y}g; \quad (27)$$

$$\frac{dq^{(f)}}{dx} = t^{(f)}t^{(f)^{Y}} \quad 4q^{(f)} \int_{f^{0}}^{X} Trft^{(f^{0})}t^{(f^{0})^{Y}}g:$$
(28)

Similarly to the SEB, the 'incoherent' scaling equations can be obtained by dropping all second order 'coherent' terms in the equations above. In this way we obtain for the dimensionless conductances $g^{(1)}$ and $g^{(2)}$ of the two junctions and the elective eld h the following scaling equations:

$$\frac{dg^{(1)}}{dx} = 4g^{(1)}(g^{(1)} + g^{(2)}); \qquad (29)$$

$$\frac{dg^{(2)}}{dx} = 4g^{(2)}(g^{(1)} + g^{(2)}); \qquad (30)$$

$$\frac{dh}{dx} = 4h (g^{(1)} + g^{(2)}) :$$
(31)

These equations can be readily solved to give:

$$g^{(1)}(\mathbf{x}) = \frac{g_0^{(1)}}{1 + 4(g_0^{(1)} + g_0^{(2)})\mathbf{x}};$$

$$g^{(2)}(\mathbf{x}) = \frac{g_0^{(2)}}{1 + 4(g_0^{(1)} + g_0^{(2)})\mathbf{x}};$$

$$h(\mathbf{x}) = \frac{h_0}{1 + 4(g_0^{(1)} + g_0^{(2)})\mathbf{x}}:$$
(32)

Thus in this approximation the only e ect of the presence of several leads is to replace the dimensionless conductance in the denominator of Eqs. (23) and (24) by the parallel conductance of all junctions attached to the island.



FIG.3. Conductance curves of Fig.2 on a linear in T plot.

In Fig. 4 we show the conductance calculated from the solution of the full scaling equations Eq. (26-28) for N = M = 15 conduction modes. Initially, both conductances follow Eqs. (32). However, at a tem perature 10^{3} E_c a single conduction m ode prevails in one of the junctions and starts to induce the two-channelK ondo e ect. The conductance of this junction approaches a universalvalue¹⁴ characteristic to the two-channelK ondo xed point while the resistivity of the other junction is suppressed to zero below this temperature. Since the tunneling between the island and this latter lead is an irrelevant operator of dim ension 1=2 and therefore its conductance scales as t² T, the total conductance of the device at the degeneracy point scales as G T, in agreem ent with M atveev's result. Note that the conductance of the other junction is universal, i.e. independent of the number of modes in the junction.

V.CONCLUSIONS

In the present work we studied in detail the physics of the single electron box and the single electron transistor close to their degeneracy points using renorm alization group methods. In particular, we investigated the e ect of cross-m ode scattering and showed that this is a relevant perturbation, and drives the system tow ards a stable two-channelK ondo xed point, a prototype of non-Ferm i liquid xed points. At very low tem peratures we recover M atvæv's m apping to the two-channel K ondo m odel:^{3;4} In this case at very low tem peratures the system dynam ically selects a single mode on the box and another one on one of the leads, and all the other modes become irrelevant. This xed point has an SU (2) SU (2) U (1) sym m etry $_{l}^{15}$ where the rst sym m etry is generated dynam ically and is connected to the structure of the effective tunneling Ham iltonian, while the second SU (2) symmetry is associated to the real spin of the electrons and is responsible for the non-Ferm i liquid behavior. The U (1) sym m etry is sim ply due to charge conservation.

D ue to this two-channel K ondo xed point the linear coe cient of the speci c heat and the capacitance of the SET diverge logarithm ically at the degeneracy point, c=T C ln (T), while the resistivity of the device diverges as $1=T^{\frac{4}{2}}$.



FIG.4. Conductance of the two junctions of the SET as calculated from the solution of the full scaling equations for N = M = 15 channels. The tunneling matrix elements were generated random by by xing the initial conductances at $g^{(1)} = 0.5$ and $g^{(2)} = 0.3$. At low temperatures the system approaches the two-channelK ondo xed point, and one of the conductances scales to a universal value while the other scales to zero.

H ow ever, as our detailed analysis dem onstrates, if the num ber of tunneling m odes is larger than one, then a new sm all energy scale T $E_C \exp(CN)$ enters into the problem, with N the total num ber of tunneling m odes. A bove this scale coherent processes leading to the K ondo physics can be neglected, and the properties of the system are very welldescribed solely in term s of the conductances of the various junctions. Neglecting the aforem entioned

coherent term swewere able to re-derive the equations of R ef. 6, and generalize them for the case of SET .

At this point we have to make an important remark. Our results for the two-channel K ondo xed point rely heavily on the fact that the electrons at temperatures T larger than the level spacing on it can hardly travel coherently from one junction to another.^{10;4} N eglecting this coherent process then one of the SET conductances scales to zero and so does the total conductance of the SET at the degeneracy point.⁴

A part from inelastic scattering, the main origin of this loss of coherence is in the random scattering from the wall of the island and the inpurities on it. Any model assuming the existence of consecutive coherent tunneling events between di erent leads gives an essentially di erent, and very likely in most situations unphysical result at very low temperatures. Indeed, repeating our analysis for the model used in Ref. 7 we nd that at T = 0 both tunnel junctions of the SET have a nite conductance at the degeneracy point, and thus the total conductance of the SET also remains nite even at zero temperature. This result is essentially di erent from the one obtained by M atveev^{3;4} or the calculations presented here, where coherent tunneling processes between di erent leads are excluded.

The di erence between these two approximations becomes even more striking for the case of an M -fold degenerate multi-degeneracy points of a multi-dot system. In this case, neglecting the above-mentioned coherent tunneling between di erent leads, we not that the low-tem perature physics is again described by the twochannel K ondo model. In the opposite case, how ever, the system would scale to another non-Fermi liquid xed point, the SU(M) SU(2) Cogblin-Schrie er xed point.

How and at what energy scale the crossover between these two behaviors happens, seem s to be presently an open question, which can only be answered by som enow incorporating m ore details about the scattering on the im purities and the energy and spatial dependence of the tunneling m atrix elements.

Because of the exponential dependence of T , even a relatively small number of tunneling modes leads to an extrem ely small T and renders the non-Ferm i liquid behavior in most cases inaccessible for the experimentalists. To observe the 2-channel K ondo behavior one can use sem iconducting or metallic quantum boxes.

Sem iconducting devices have the advantage that using suitable gate electrodes one can realize the idealistic case of a single mode contact, and therefore T E_{C} can be achieved. There is a serious di culty, how ever, since one should keep E_C large enough in order to have a measurable K ondo tem perature while having a small level spacing on the island, the latter playing the role of an infrared cuto for the K ondo physics. The form er requirem ent im m ediately sets an upper lim it on the size of the box $d < e^2 = E_C$ 1000A, and therefore a lower lim it on the mean level spacing $1 = (m d^2)$ 0:1 1K , where we assumed a two dimensional electron gas with

e ective mass m . This means that even if one manages to build a sem iconducting device with a K ondo tem perature in the measurable range, the level spacing will be too large to observe the two-channel K ondo behavior in detail. Indeed, even in the very recent experiments of R ef.5 the ratio $E_c =$ was in the range 100, and consequently only some ngerprints of the two-channel K ondo behavior could have been observed. For smaller islands E_c would becom e larger, how ever, the ratio $E_c =$ would get even worse. Therefore there seems to be no hope to investigate the two-channel K ondo behavior with sem iconducting devices more in detail.

The other possibility is to prepare metallic boxes. Since these metallic boxes are three dimensional objects and m m_e (unlike sem iconducting devices with m m_e), metallic grains of the size of only d 100A may have quite large E_c 100 500K, and very small mean level spacing on the other hand. Indeed, using STM devices to tunnel into metallic drops¹⁶ it was possible to observe the Coulomb blockade even at room temperature.¹⁷

The di culty in this case is connected to the preparation of the junctions. As emphasized earlier, one needs practically single mode or at most few mode junctions in order to have T large enough, which requires atom ic size contacts/junctions. To establish such a junction we propose the experimental setup illustrated in Fig. 5. In the suggested experiment a metallic electrode is covered by a thin insulating layer, and a metallic drop is deposited on the top of it. The atom ic size contacts can be formed by plugging an STM needle into one of the drops and then gently pulling it out of it.¹⁸ An additional gate electrode should be built in the vicinity of the drop to control the charging of the island. The two-channel K ondo e ect would then show up in the gate voltage dependence of the conductance through the island.



FIG. 5. Sketch of an STM setup to observe the two-channel K ondo behavior. The external gate electrode over the insulating layer is used to tune the m etallic droplet to its degeneracy point.

The biggest diculty in the experiment above is to

establish a stable contact, so that one has enough tim e to tune the drop to its degeneracy point and carry out the m easurem ent. It would be much more advantageous to use nanotechnology to build atom ic size contacts instead of using an STM, a possibility which may be not too far away any more.

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